3	earch N	lotes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/766,776	DOAN, JONATHAN	
Examiner	Art Unit	
Eric B. Chen	1765	

	SEARCHED		
Class	Subclass	Date	Examiner

ТИІ	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NO' (INCLUDING SEARCH)
	DATE	EXMR
Inventor search	12/6/2005	EC
EAST (all databases) - see search history printout	12/8/2005	EC
216/2,24,58,63,67,79; 359/290-293 (text search only) (consulted S. Ahmed, AU 1765)	12/8/2005	EC
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